



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>09910778</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>OKADA, HIDEHIKO</p>
	<p>Examiner</p> <p>Tan, Alvin H</p>	<p>Art Unit</p> <p>2173</p>

Class	SubClass	Date	Examiner
715	740	6/16/05	AT
715	867	12/22/05	AT
Above	UPDATED	10/16/06	AT
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<b>Search Notes</b>  	Application/Control No.  09910778	Applicant(s)/Patent Under Reexamination  OKADA, HIDEHIKO
	Examiner Tan, Alvin H	Art Unit 2173

Notes	Date	Examiner
715/864(text search only - see search history printout)	05/01/0614	AT
715/765 (text search only - see search history printout)	06/17/2005	AT
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	06/14/2005	AT
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